Search Notes			

Application No.	Applicant(s)	
10/071,370	BAYNE ET AL.	
Examiner	Art Unit	
Jon M Lockard	1647	

_	SEARCHED			
Class	Subclass	Date	Examiner	
424	198.1	9/21/2004	JML	
435	69.1			
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530	350			
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536	23.5			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Stic Search of Commercial and Patent Databases: See Attached Search Report	9/17/2004	JML
East Search: Text and Inventors Name Search: See attached Search Report.	9/21/2004	JML
PALM: Inventor's Name Search: See Attached Search Report	9/21/2004	JML
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